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1 Two-scale model and ocean radar Doppler spectra at moderate- and grazing angles

Zavorotny, V.U.; Voronovich, A.G.;

Antennas and Propagation, IEEE Transactions on , Volume: 46 , Issue: 1 , Jan 1998

Pages:84 - 92

[\[Abstract\]](#) [\[PDF Full-Text \(304 KB\)\]](#) **IEEE JNL**

2 Pronunciation variation analysis based on acoustic and phonemic distance measures with application examples on Mandarin Chinese

Ming-Yi Tsai; Lin-Shan Lee;

Automatic Speech Recognition and Understanding, 2003. ASRU '03. 2003 IEEE Workshop on , 30 Nov.-3 Dec. 2003

Pages:117 - 122

[\[Abstract\]](#) [\[PDF Full-Text \(614 KB\)\]](#) **IEEE CNF**

3 A case study in ultrasonic cleaning damage

Mallette, L.A.; Chen, I.; Johnson, T.W.;

Aerospace Conference, 1998. Proceedings., IEEE , Volume: 3 , 21-28 March 1998
 Pages:77 - 80 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(556 KB\)\]](#) **IEEE CNF**

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